ŢF		F INFORMATION DIS Under 37 CFR 1.97(b), (Docket No. 7989/ETCH/SILICON/JB
In re A		iu, et al.	(6), 01	(W) - Charles and the second of the second o	7909/ETCH/SILICON/JB
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1. 🛛	application other the entry of the national	isclosure Statement submitted nan a continued prosecution a al stage as set forth in 37 CFR is; or before the mailing of a fi	d herewapplica applica 1.491	vith is being filed within three mon tion under 37 CFR 1.53(d); within in an international application; befo ce Action after the filing of a reque	three months of the date of re the mailing of a first Office
				1.97(c)	
2.	The Information Disclosure Statement submitted herewith is being filed after the period specified in 37 CFR 1.97(b), but prior to the mailing date of a Final Action under 37 CFR 1.113, a Notice of Allowance under 37 CFR 1.311, or an Action that otherwise closes prosecution in the application, and is accompanied by the statement or fee as indicated below.				
				1.97(d)	
3. The Information Disclosure Statement submitted herewith is being filed after the period specified in 37 CFR 1. on or before payment of the issue fee and is accompanied by the statement and fee as indicated below.					cified in 37 CFR 1.97(c), but cated below.
				es Under 37 CFR 1.97(c)	
	 Each item of information contained in the accompanying Information Disclosure Statement was first cited is communication from a foreign patent office in a counterpart foreign application not more than three months to the filing of the Information Disclosure Statement. (37 CFR 1.97(e)(1)) No item of information in the accompanying Information Disclosure Statement was cited in a communic from a foreign patent office in a counterpart foreign application, and, to the knowledge of the underst person, after making reasonable inquiry, no item of information contained in the accompanying Inform Disclosure Statement was known to any individual designated in 37 CFR 1.56(c) more than three months to the filing of the Information Disclosure Statement. (37 CFR 1.97(e)(2)) 				
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4.	foreign patent office	in a counterpart application a	and this	on Disclosure Statement was cited communication was not received g of the Information Disclosure Stat	ov any individual designated
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Mose	No. 45,150 r, Patterson & Sh neys at Law	ieridan, LLP	/	I certify that this document is being with the U.S. Postal Service as firs and is addressed to the Commission 1450, Alexandria, VA 22313-1450	t class mail under 37 CFR §1.8
595 Shrewsbury Avenue, Suite 100 Shrewsbury, New Jersey 07702				Signature of Person Mai	ing Correspondence
732-530-9404				Barbara J.	1
				Typed or Printed Name of Pers	

Sheet 1 of 1 sheets U.S. Department of Commerce, Patent and Trademark Office Docket No. Serial No. (PTO Form 1449 modified) 7989/ETCH/SILICO 10/665,934 N/JB INFORMATION DISCLOSURE STATEMENT BY APPLICANT **Applicant** Confirmation Liu, et al. No. (Use several sheets if necessary) Filing Date Group Examiner 09/19/2003 PADEWOR **U.S. Patent Documents** *Examiner Document Issue Applicant(s) Class Subclass Filing Date If Initial Number Date Name **Appropriate A1** 5,926,690 07/20/1999 Toprac, et al. 438 17 A2 6,388,253 05/14/2002 Su 250 310 **A3** 6,424,417 07/23/2002 Cohen, et al. 356 388 **A4** 6,486,492 11/26/2002 Su 257 48 A5 A6 **A7 8A** A9 A10 A11 A12 **Foreign Patent Documents** *Examiner Document Date Country Class Subclass Translation Initial Number YES NO **B1** B2 B3 **B**4 **B5 OTHER ART** *Examiner Including Author, Title, Date, Initial Pertinent Pages, Etc. C₁ C2 **C3** Examiner **Date Considered** *EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through

citation if not in conformance and not considered. Include copy of this form with your communication to applicant.